


<b>Search Notes</b>  	<b>Application/Control No.</b>  10055580	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Mitchell, James M	<b>Art Unit</b>  2813

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
257/737,778,779,780 (see printout)	5/07/08	Jmm

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner